

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

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Yoshiharu KOBAYASHI et al.FILING DATE  
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GROUP

## U.S. PATENT DOCUMENTS

| *EXAMINER<br>INITIAL |    | DOCUMENT<br>NUMBER | DATE    | NAME             | CLASS | SUBCLASS | FILING DATE IF<br>APPROPRIATE |
|----------------------|----|--------------------|---------|------------------|-------|----------|-------------------------------|
| /LB/                 | AA | 5,289,407          | 2-22-94 | Strickler et al. |       |          |                               |
|                      | AB |                    |         |                  |       |          |                               |
|                      | AC |                    |         |                  |       |          |                               |

## FOREIGN PATENT DOCUMENTS

|      |    | DOCUMENT<br>NUMBER | DATE    | COUNTRY | CLASS | SUBCLASS | TRANSLATION<br>YES NO |
|------|----|--------------------|---------|---------|-------|----------|-----------------------|
| /LB/ | AD | 11-232677          | 8-27-99 | Japan   |       |          | abstract              |
| /LB/ | AE | 2003-77158         | 3-14-03 | Japan   |       |          | abstract              |
| /LB/ | AF | 2003-16680         | 1-17-03 | Japan   |       |          | abstract              |
|      | AG |                    |         |         |       |          |                       |
|      | AH |                    |         |         |       |          |                       |

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

|      |    |   |
|------|----|---|
| /LB/ | AI | 3.2 Disk Design Technology, Matsushita Technical Journal, Vol. 45, No. 6, December 1999, pages 672-678 (along with abstract)  |
| /LB/ | AJ | M. Miyamoto et al., "Analysis to reduce cross erase for phase-change optical disks", The Institute of Electronics, Information and Communication Engineers, Technical Report of IEICE.CPM2000-95 (2000-09), pages 21-27 (along with abstract) |
| /LB/ | AK | Mark A. A. Neil et al., "New modal wave-front sensor: a theoretical analysis", J. Opt. Soc. Am. A/Vol. 17, No. 6/ June 2000, pages 1098-1107  |
| /LB/ | AL | Carlos Robledo-Sánchez et al., "Aberration extraction in the Hartmann test by use of spatial filters", Applied Optics, Vol. 38, No. 16, June 1, 1999, pages 3483-3489   |
| /LB/ | AM | M. A. A. Neil et al., "Closed-loop aberration correction by use of a modal Zernike wave-front sensor", Optics Letters, August 1, 2000, Vol. 25, No. 15, pages 1083-1085   |
| /LB/ | AN | Mark A. A. Neil et al., "Active aberration correction for the writing of three-dimensional optical memory devices", Applied Optics, Vol. 41, No. 7, March 1, 2002, pages 1374-1379  |

EXAMINER

/LaTanya Bibbins/

DATE CONSIDERED

05/30/2009